High Dynamic Range Low Noise GaAs FET



August 2006 - Rev 03-Aug-06 CFB0303

Features

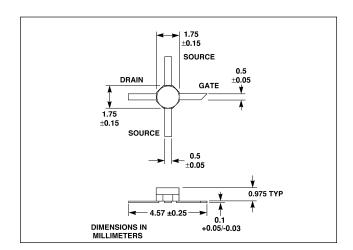
- ☐ Low-Noise Figure from 0.8 to 2.0 GHz
- ☐ High Gain
- ☐ High Intercept Point
- ☐ Highly Stable
- \Box Easily Matched to 50Ω
- ☐ 70 mil Package
- **□** PHEMT Material

Applications

- ☐ Cellular Base Stations
- **□** PCS Base Stations
- ☐ Industrial Data Networks

Description

Celeritek's CFB0303 is a high performance GaAs PHEMT with 600 μ m gate width and 0.25 μ m gate length. The low noise figure and high intercept point of this device makes it well suited for use as the low-noise amplifier of the



base station receiver in PCS, Japanese PHS, AMPS, GSM and other communications systems. The CFB0303 is in an industry-standard 70 mil package. It is surface mountable and available in tape and reel.

Electrical Specifications (TA = 25°C, 2 GHz)

| Parameters | Conditions | Min | Тур | Max | Units |
|--|---|------|------|------|-------|
| $V_d = 4V$, $I_d = 75 \text{ mA}$ | | | | | |
| Noise Figure ² | | | 0.5 | 0.6 | dB |
| Associated Gain ² | @ Noise Figure | 19.0 | 20.0 | 22.7 | dB |
| P _{out} 1, 3 | P ₋₁ | 20.0 | 21.0 | 22.0 | dBm |
| $\overline{\text{IP}_3^3}$ | +5 dBm P _{OUT} /Tone | 32 | 34 | | dBm |
| I_d^3 | @ P ₋₁ | | 83 | | mA |
| Transconductance | $V_{ds} = 4 \text{ V}, V_{gs} = 0 \text{ V}$ | | 350 | | mho |
| Saturated Drain Current | $V_{ds} = 4 \text{ V}, V_{gs} = 0 \text{ V}$ | 80 | 140 | 240 | mA |
| Pinchoff Voltages | $V_{ds} = 4 \text{ V}, I_{ds} = 1 \text{ mA}$ | | -0.3 | | V |
| Thermal Resistance @ T _{case} = 150°C liquid crystal test | | | 200 | | °C/W |

Notes: 1. @ $T_{case} = 25$ °C. Derate 5 mW/°C for $T_{case} > 25$ °C.

- 2. Input matched for low noise.
- 3. Matched for power transfer.

Typical Scattering Parameters (TA = 25°C, V_{DS} = 4 V, I_{DS} = 75 mA)

| Frequency (GHz) | S | 11 | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|--------------------|------|------|-----------------|-----|-----------------|-----|-----------------|-----|
| | Mag | Ang | Mag (dB) | Ang | MAG (dB) | ANG | MAG | ANG |
| 0.5 | 0.98 | -24 | 8.47 | 160 | 0.02 | 77 | 0.33 | -9 |
| 1.0 | 0.94 | -44 | 8.20 | 147 | 0.03 | 69 | 0.32 | -15 |
| 2.0 | 0.85 | -80 | 7.30 | 118 | 0.05 | 51 | 0.27 | -36 |
| 3.0 | 0.76 | -112 | 6.30 | 94 | 0.07 | 37 | 0.25 | -50 |
| 4.0 | 0.70 | -134 | 5.60 | 74 | 0.08 | 29 | 0.24 | -55 |
| 5.0 | 0.64 | -154 | 5.13 | 54 | 0.09 | 19 | 0.23 | -61 |

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$\textbf{Typical Noise Parameters} \ \ (V_{ds} = 4 \ V, \ I_{ds} = 75 \ mA)$

| Frequency | F _{min} ¹ | Gamn | na Opt | |
|-----------|-------------------------------|------|--------|-------|
| (GHz) | (dB) | Mag | Ang | Rn/50 |
| 0.8 | 0.4 | 0.6 | 27 | 0.19 |
| 1.0 | 0.4 | 0.6 | 29 | 0.17 |
| 1.2 | 0.4 | 0.6 | 32 | 0.18 |
| 1.4 | 0.4 | 0.6 | 35 | 0.18 |
| 1.6 | 0.4 | 0.5 | 38 | 0.17 |
| 1.8 | 0.4 | 0.5 | 41 | 0.16 |
| 2.0 | 0.5 | 0.5 | 45 | 0.15 |
| 2.2 | 0.5 | 0.5 | 49 | 0.15 |
| 2.4 | 0.5 | 0.5 | 54 | 0.14 |
| 2.6 | 0.5 | 0.5 | 60 | 0.13 |

Note: 1. Fmin values reflect the circuit losses in the test fixture when matched to optimum noise figure.

Absolute Maximum Ratings

| Parameter | Symbol | Rating |
|-------------------------------------|-----------------------------------|-----------------|
| Drain-Source Voltage | V _{ds} | +8V |
| Gate-Source Voltage | $V_{\sigma s}^{as}$ | -5V |
| Drain Current | ${ m v}_{ m gs} \ { m I}_{ m ds}$ | Idss |
| Continuous Dissipation ¹ | Pt | 750 mW |
| Channel Temperature | Tch | 175°C |
| Storage Temperature | Tstg | -65°C to +150°C |

Notes